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VOLPE-KOENIG

**☑** 003/006

Applicant: Tseng et al.

Application No.: 10/758,628

Amendments to the Claims:

(cancelled) 1.

(currently amended) The ferroelectric memory structure according to elaim 1 2.

claim 10, wherein said substrate is a silicon substrate.

(original) The ferroelectric memory structure according to claim 2, wherein 3.

said silicon substrate is a p-type silicon substrate.

(original) The ferroelectric memory structure according to claim 2, wherein 4.

said silicon substrate is a n-type silicon substrate.

(currently amended) The ferroelectric memory structure according to elaim 1 5.

claim 10, wherein said insulating layer is made of BaxSr1-xTiO3, wherein the x is in

a range between 0.3 and 1.

(original) The ferroelectric memory structure according to claim 5, wherein 6.

said insulating layer is doped by MgO.

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**2**1004/006

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(currently amended) The ferroelectric memory structure according to elaim 1 7.

claim 10, wherein said plurality of oxide electrodes are made of LaNiO<sub>3</sub>.

(currently amended) The ferroelectric memory structure according to claim 1 8.

claim 10, wherein said ferroelectric layer is made of BixLa4-xTi3O12, wherein x is in

a range between 0 and 1.

(currently amended) The ferroelectric memory structure according to elaim 1 9.

claim 10, wherein said plurality of metallic electrodes are made of one of noble

metals selected from a group consisting of Pt, Ru and Ir, and an oxide electrode

containing a perovskite structure and comprising one selected a group consisting of

LaNiO<sub>3</sub>, SrRuO<sub>3</sub>, BaRuO<sub>3</sub> and YBa<sub>2</sub>Cu<sub>3</sub>O<sub>7</sub>.

(currently amended) The ferroelectric memory structure according to claim 10.

10,

A ferroelectric memory structure, comprising:

a substrate;

an insulating layer formed on said substrate;

a plurality of oxide electrodes formed on said insulating layer;

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**2**005/006

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a ferroelectric layer formed on said insulating layer and said plurality of oxide

electrodes; and

a plurality of metallic electrodes formed on said ferroelectric layer and

corresponding to said plurality of said oxide electrodes;

wherein said plurality of metallic electrodes respectively have a first electrode area,

and said plurality of oxide electrodes respectively have a second electrode area,

wherein a ratio of said first electrode area to said second electrode area is less than

1/12.

11-37. (cancelled)